

GaAsSb/AlGaAs Superlattice High-Polarization Electron Source

Contract # DE-SC0007501

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Subcontractor: DoE Jefferson Lab (Matt Poelker)

DoE SBIR/STTR Exchange Meeting

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SVT Associates Company Overview

Founded in 1993 as Molecular Beam Epitaxy (MBE) equipment provider

- Originated from Perkin Elmer Physical Electronics MBE Group
- One of today's leading MBE suppliers by continual product development
- Over 160 MBE systems now in the field (Over 25 MBE Systems in Asia)
- Strong UHV hardware, epitaxial growth, and thin film expertise
- Technology Driven Company
 - >30% employees are PhD scientists (currently 35 employees total)
 - Key engineers > 25 years experience in MBE and UHV technology
- Diverse system product line spanning Molecular Beam Epitaxy (MBE), Thin Film Deposition (i.e. ALD, PVD, PLD and Solar), and In-situ Thin Film Monitoring
- Only MBE Company with System, Components, Process, In-situ Monitoring Expertise with our own Applications Laboratory and Characterization Facility



SVT Facilities and Capabilities

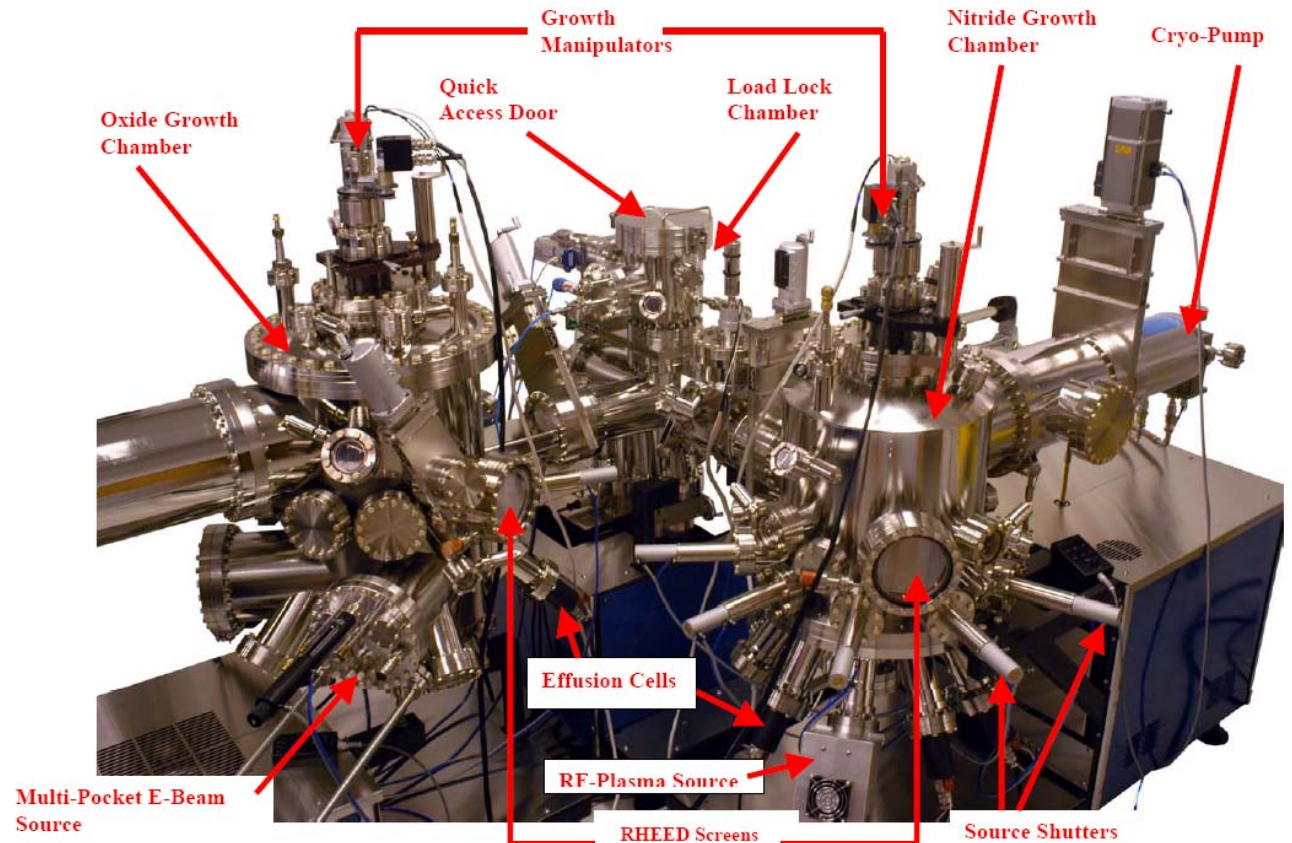
- Material deposition systems: MBE
PLD, ALD

Established know-how:
8 Applications Laboratory MBE
systems producing world class
epitaxial growth, feeding
requirements back to equipment
designers

- Complete semiconductor
material characterization facility:
HR-XRD, FTIR, Hall, Low-temp
probe station, Semiconductor
parameter analyzer,
ellipsometer.

- Device Fabrication

Class-100 clean room, ICP dry
etcher.



Dual Oxide - Nitride MBE



Semiconductors Research at SVT

- US government, industrial research grants, and internal programs
- Established research collaboration with many universities: Illinois, North Carolina State, Florida, Stanford ...
- Highly technically oriented, PhD scientists & engineers
- > 100 book chapters, publications and presentations
- Significant Antimonide, Nitride and ZnO accomplishments
 - High power HEMT & MOSHEMT
 - Commercialized solar blind UV detector products
 - High efficiency photocathode
 - Innovative LED utilizing Quantum Structures
 - New mid Infrared Laser and Photodiode
 - Rainbow colored MgZnCdO



Program Overview

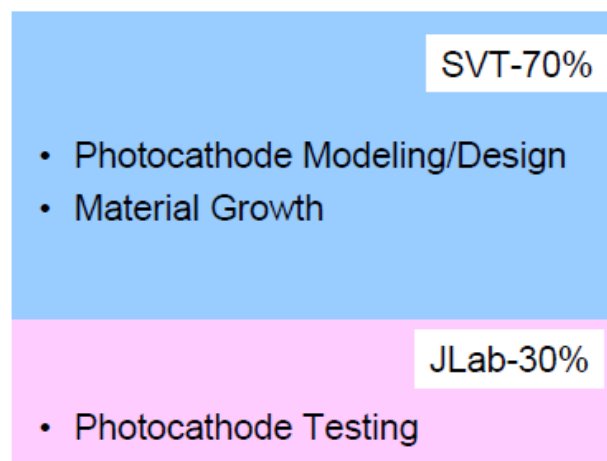
Program title: GaAsSb/AlGaAs Superlattice High-Polarization Electron Source

Ultimate goal:

cw polarized electron sources with >80% polarization and >10 mA beam current

Present Applications:

- DoE needs: high energy accelerators
- Spintronics



Potential Applications:

- Surface analysis
- Quantum computing
- Magnetic imaging



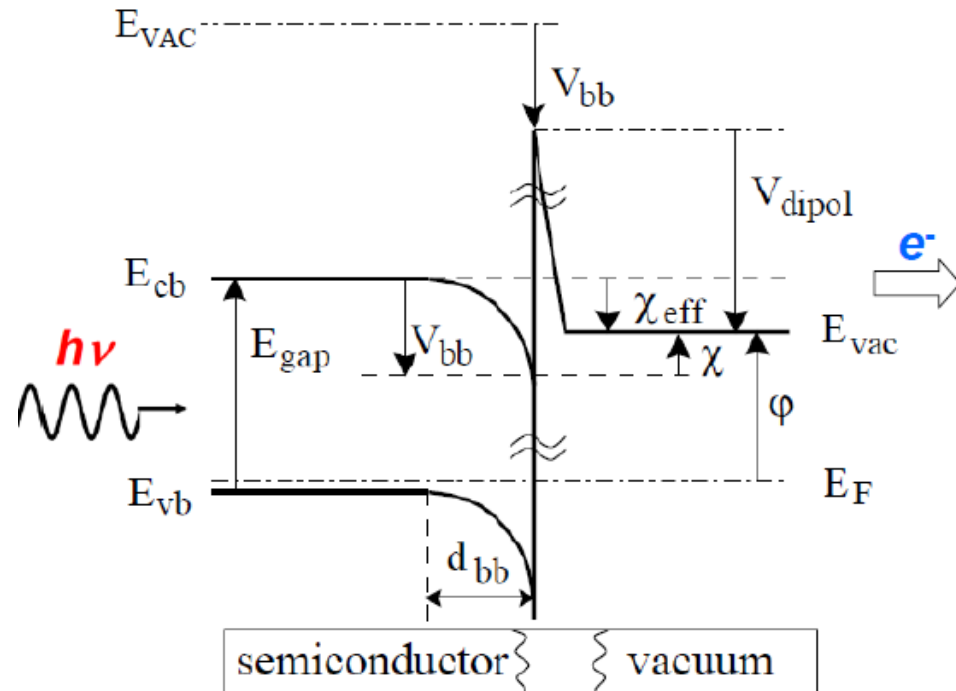
Photocathode - General Properties

1. Optical absorption
2. Electron transport to surface
3. Escape from surface to vacuum

Two aspects of emitted electrons in polarized photocathode: density and spins

- Improvement:
1. increase QE
 2. increase polarization

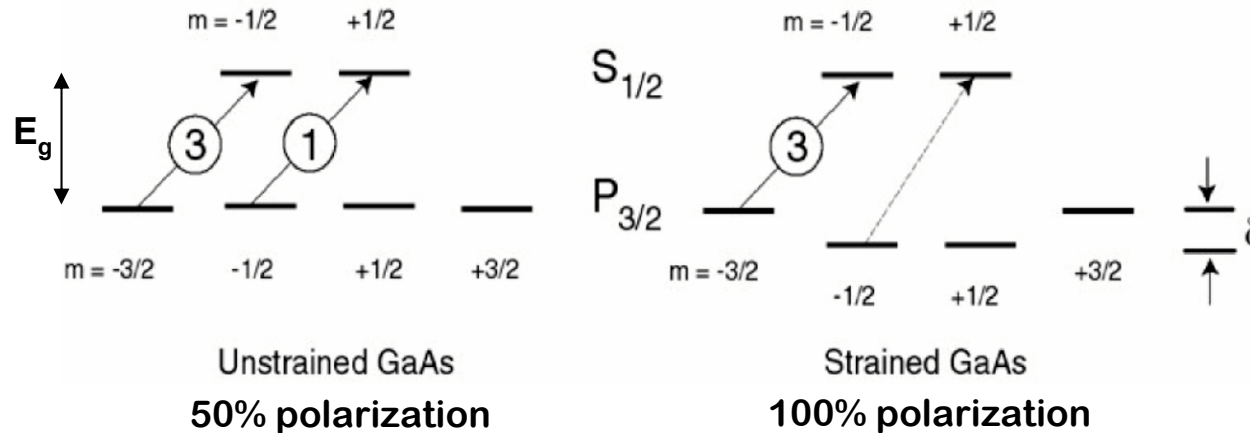
Photons \rightarrow free electrons in vacuum



Basics of polarized electron photocathode

Semiconductor: suitable material for polarized photocathodes

Non-zero transition matrix elements for semiconductors under circular-polarized light illumination



Strained SL : highest polarization (HH-LH splitting further increased due to the quantum confinement by SL)

Initial polarization:
$$P_0 = (n_{\uparrow} - n_{\downarrow}) / (n_{\uparrow} + n_{\downarrow})$$

Why GaAsSb/AlGaAs SL?

Existing structures in literature

1. InGaAs/AlGaAs (strained well), 70-80%, QE~0.7%
 2. GaAs/GaAsP (strained well), 92%, measured, QE~1%
 3. GaAs/AlInGaAs (strained barrier), 91%
 4. AlInGaAs/GaAsP (strain-balanced), 84%
 5. AlInGaAs/AlGaAs (strained well), 92% with QE~0.85%
- } All HH-LH splittings < 95 meV

GaAs/GaAs_{0.64}P_{0.36} SL:

Best overall performance thus far, HH-LH splitting $\delta \sim 92$ meV

GaAs_{0.85}Sb_{0.15}/Al_{0.4}Ga_{0.6}As SL:

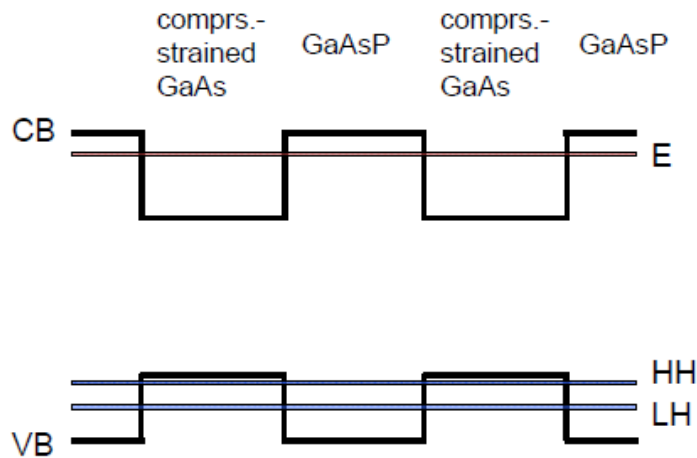
- highest VB offset \Rightarrow Highest HH-LH splitting: $\delta \sim 168$ meV resulting in highest initial polarization and larger tolerance to γ
- Dislocation-free SL material since no strain relaxed layer required, boost QE
- No need to grow very thick metamorphic buffer (5-10 μm), cost-effective

GaAsSb/AlGaAs SL Photocathode – High Polarization and High QE

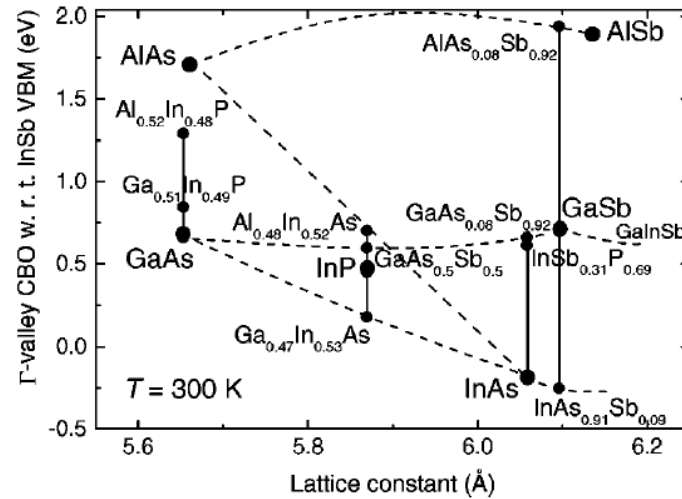
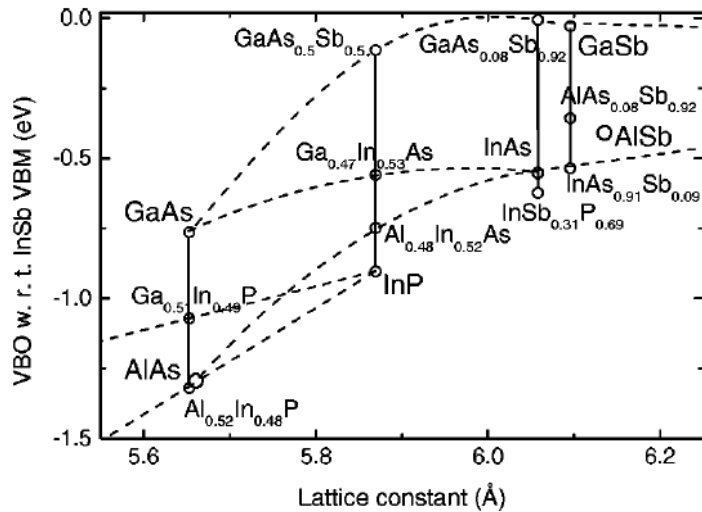
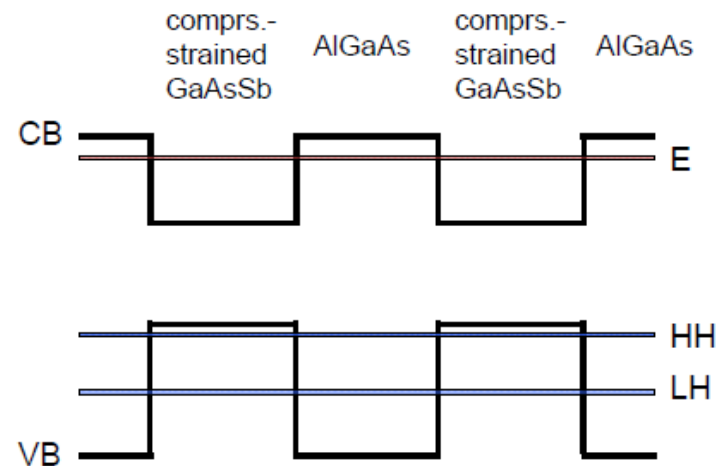


Very High VB offset in GaAsSb/AlGaAs Heterostructure

GaAs/GaAsP SL

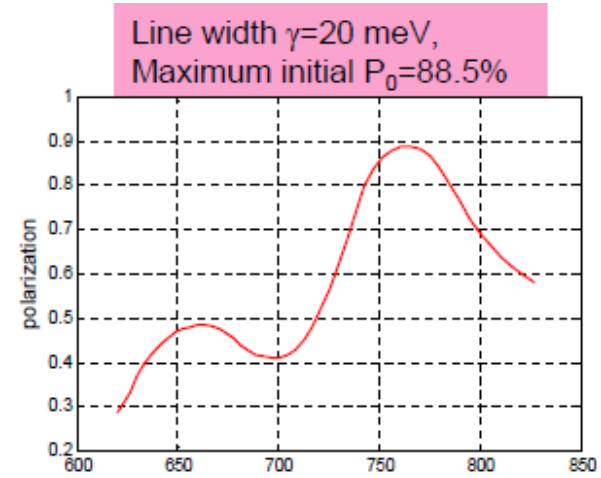
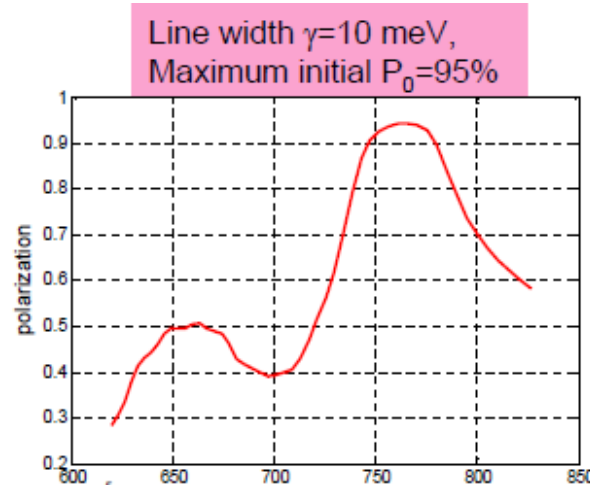


GaAsSb/AlGaAs SL

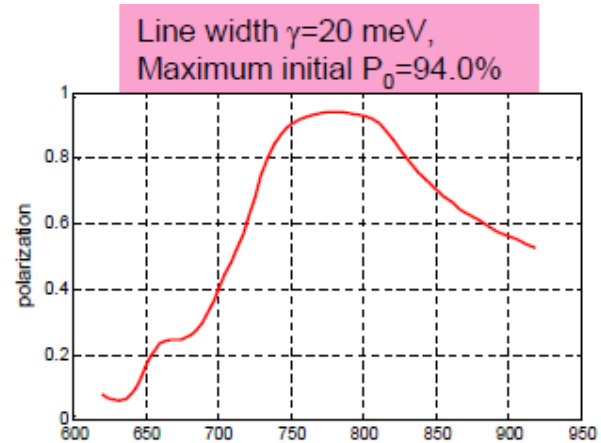
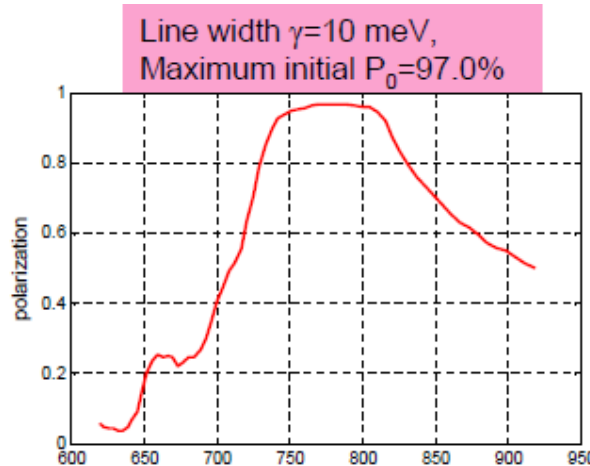


GaAsSb/AlGaAs SL: wider high P_0 range and larger tolerance to γ

GaAs/GaAs_{0.64}P_{0.36} SL



GaAs_{0.85}Sb_{0.15}/AlGaAs SL

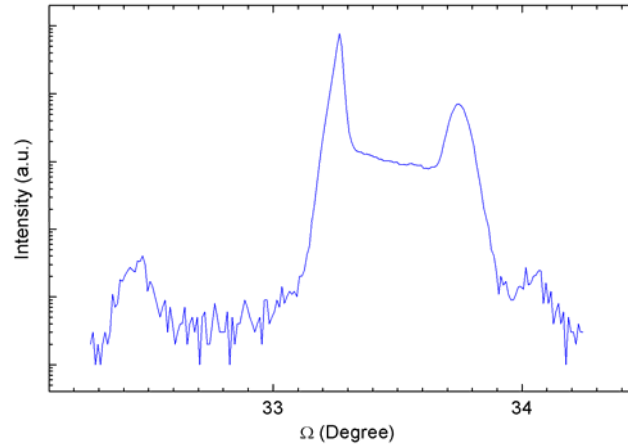


Broadening of band: $\delta(\omega_{m'}(\vec{k}_{\parallel}, k_z) - \omega) \rightarrow \frac{1}{\pi} \text{Im} \frac{1}{\omega - \omega_{m'}(\vec{k}_{\parallel}, k_z) - i\gamma}$

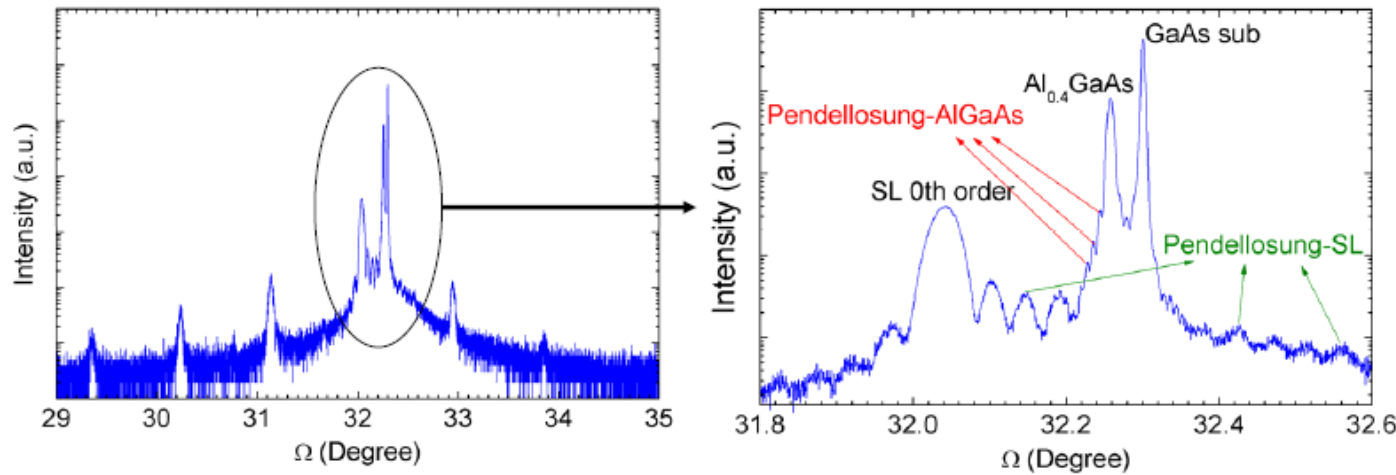


Much Better Crystalline Quality Material : GaAsSb/AlGaAs SL

Higher order satellite peaks and Pendellosung fringes observed indicate better quality SL materials.



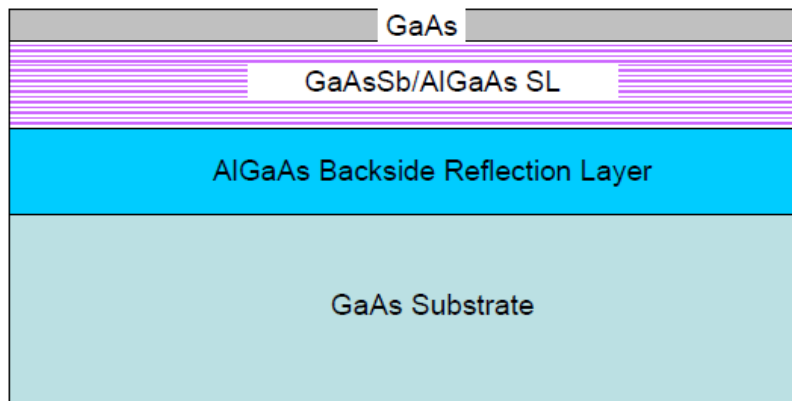
(Left)
XRD rocking curve for GaAs/GaAsP SL on 5um GaAsP buffer grown on GaAs substrate.



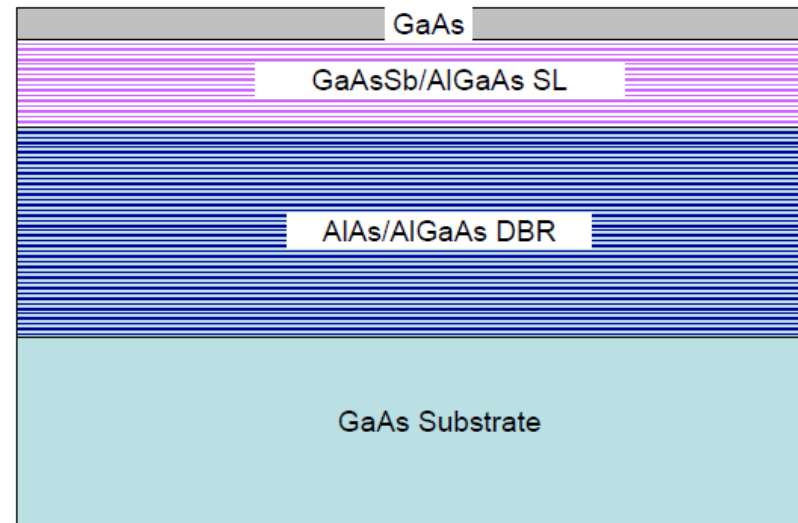
XRD rocking curve for GaAsSb/AlGaAs SL grown on GaAs.

GaAsSb/AlGaAs SL Photocathode Wafer Structures

GaAsSb/AlGaAs SL
photocathode w/o DBR



GaAsSb/AlGaAs SL
photocathode w/ DBR



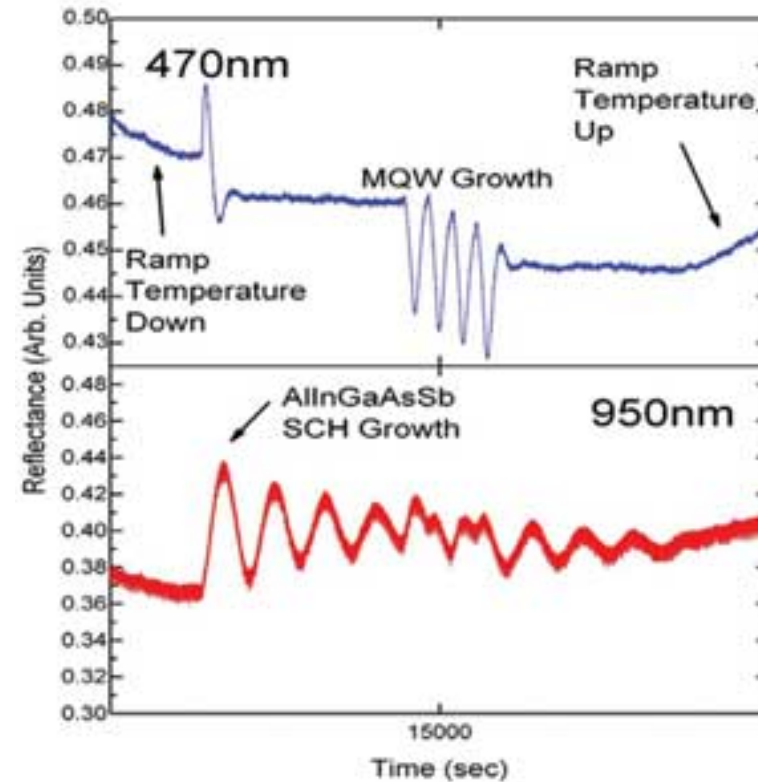
Accurate Temperature Control for Mixed Group-V Materials

GaAsSb: As/Sb composition highly dependent on growth temperature

AccuTemp™ In-Situ 4000 Process Monitor

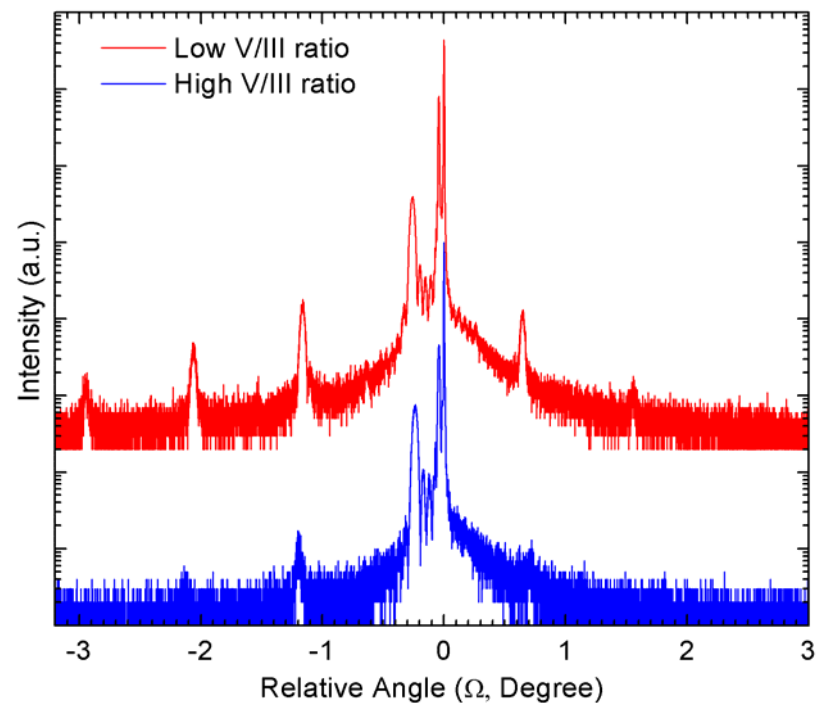
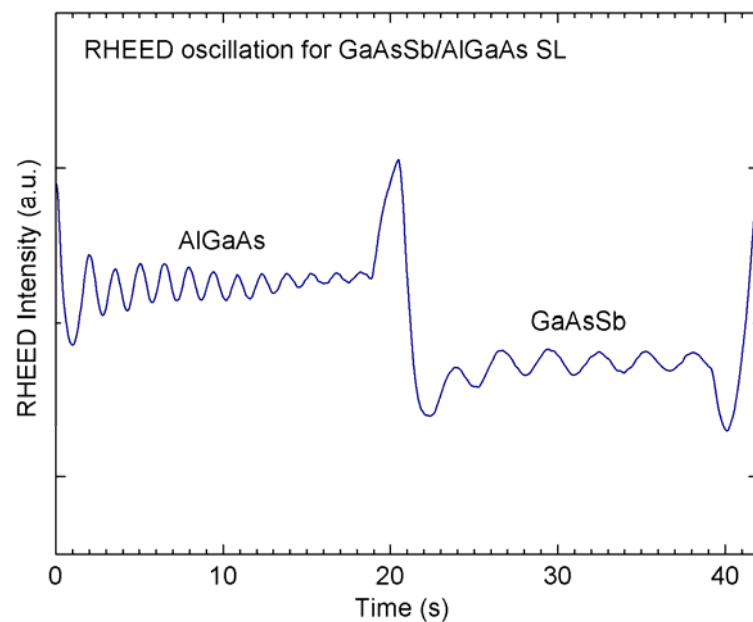


Temperature equivalent noise: <math><0.5\text{C}</math>



High Quality GaAsSb/AlGaAs SL Grown by MBE

- Strong RHEED oscillations during whole process of MBE growth
- Up to 4th order satellite peaks observable in HRXRD rocking curves



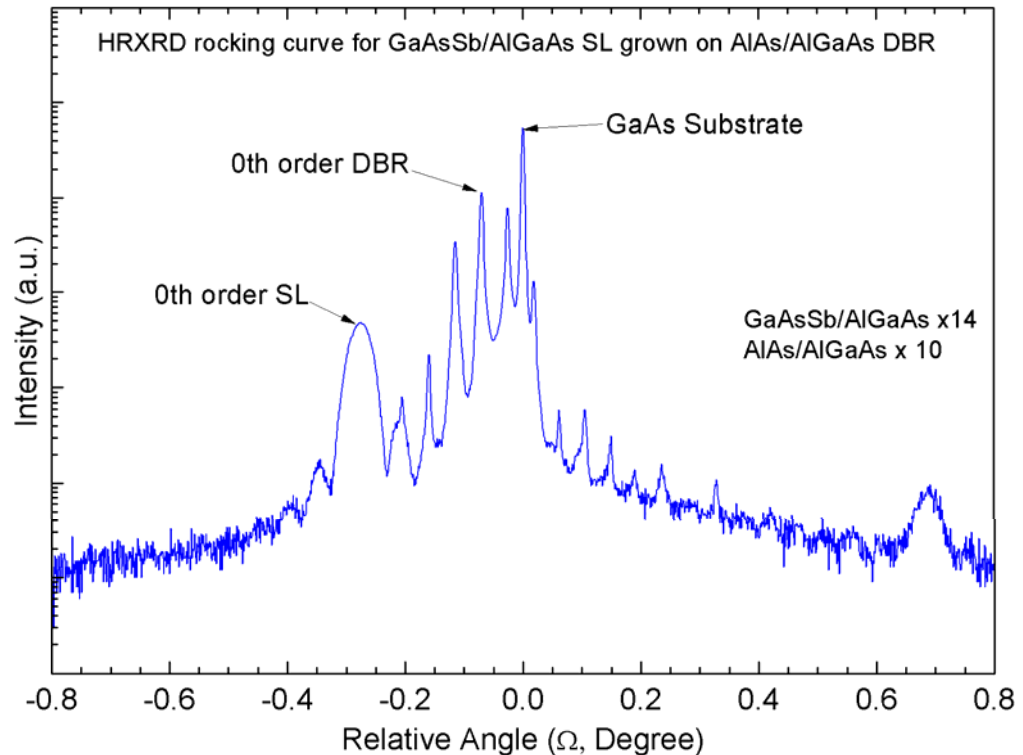
MBE Growth of AIAs/AlGaAs DBRs

Calibration of MBE growth of AIAs/AlGaAs DBR completed

Main challenge of growth of AIAs/AlGaAs DBR:

large growth temperature difference between AIAs (705 °C) and AlGaAs (615 °C).

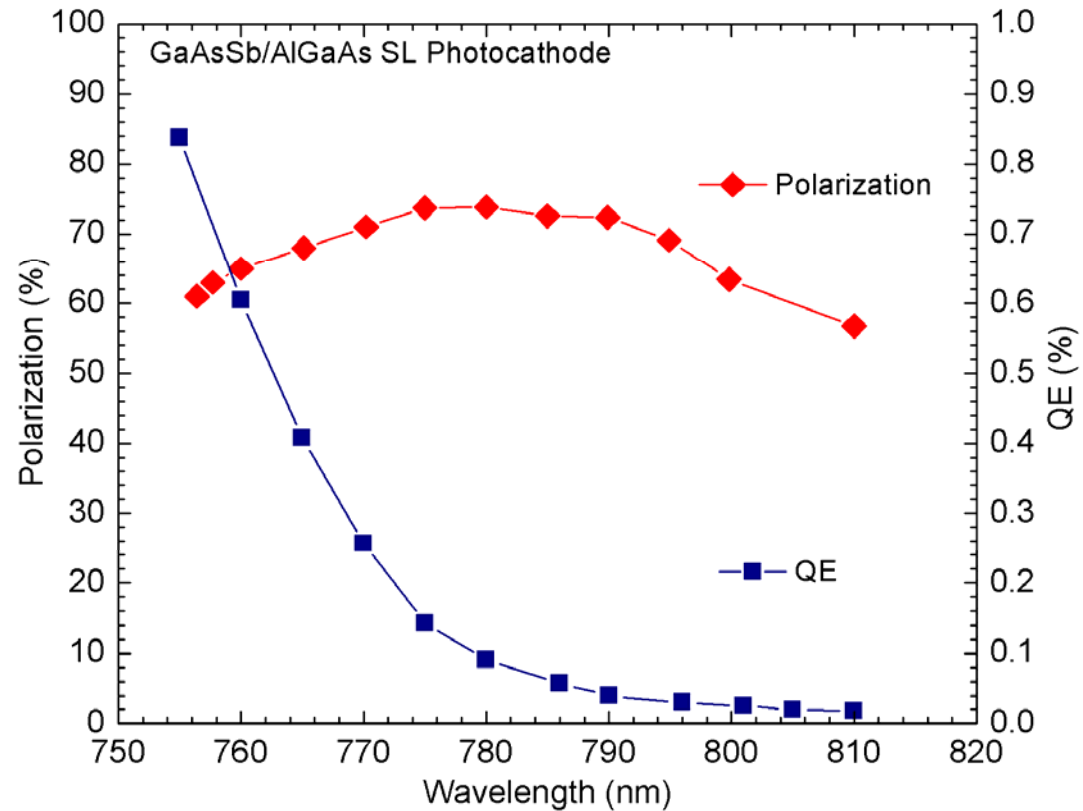
A special recipe developed for MBE growth of AIAs/AlGaAs DBRs



HRXRD rocking curve for $\text{GaAs}_{0.85}\text{Sb}_{0.15}/\text{Al}_{0.38}\text{Ga}_{0.62}\text{As}$ (x14) SL grown on $\text{AlAs}/\text{Al}_{0.25}\text{Ga}_{0.75}\text{As}$ (5.6nm/6.3nm x10) DBR on GaAs (100) substrate.

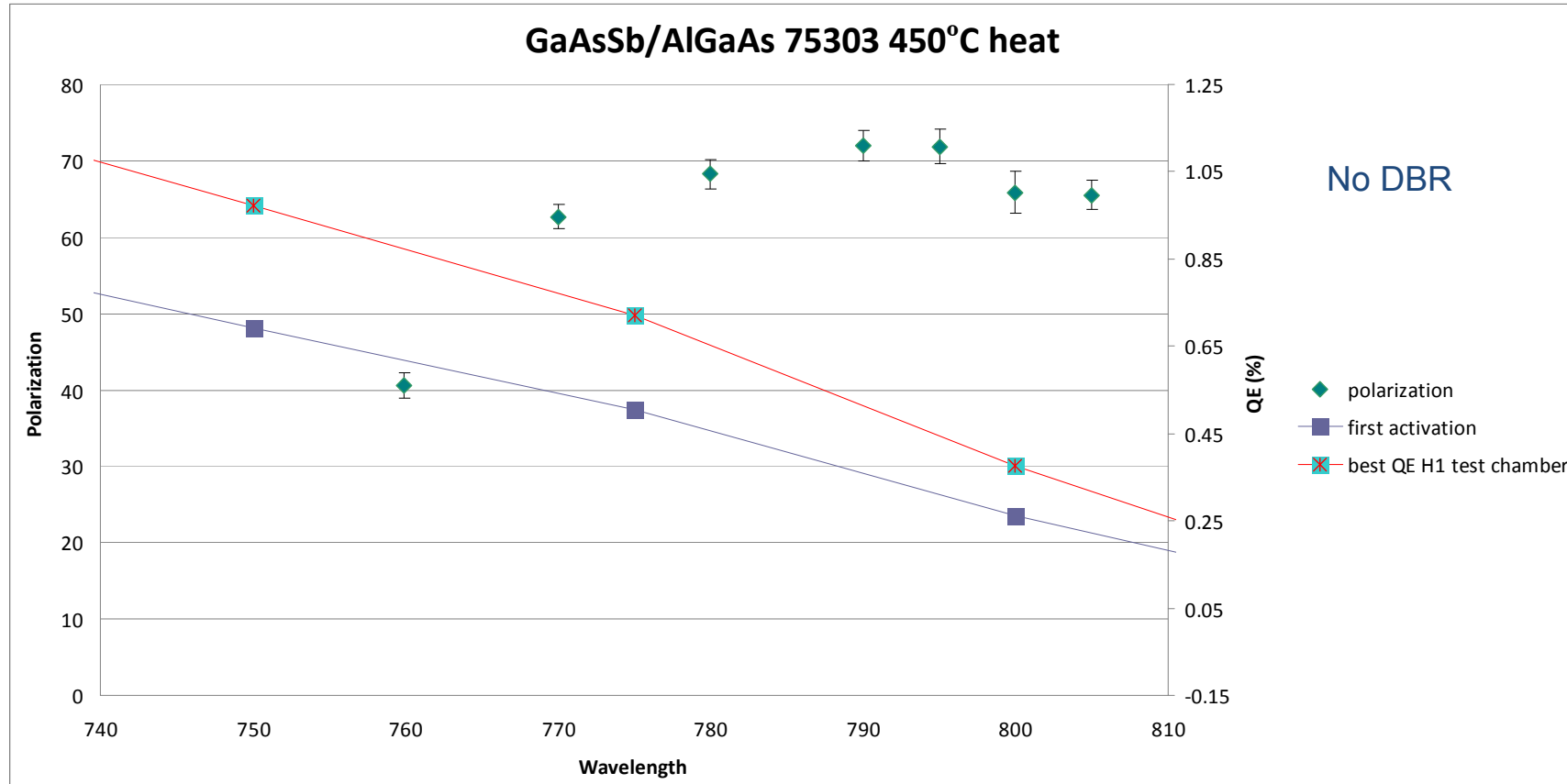
GaAsSb/AlGaAs SL Photocathode – Testing Results (1st batch)

- Up to 73% polarization achieved
- QE very low ~0.1%



Polarization and quantum efficiency for a fabricated GaAsSb/AlGaAs superlattice photocathode (w/o DBR).

GaAsSb/AlGaAs SL Photocathode – Testing Results (2nd batch)



Better QE by improved As capping process.
The polarization is still below expected P_0 . What's the reason?

Possible Reasons for Low Polarization

Strain relaxation, transport loss, and spin relaxation

$$P = P_0 B_s \frac{\tau_s}{\tau_s + \tau_t}$$

Surface loss Transport loss

τ_s : spin relaxation time, τ_t : the transport time.

- Some SL layer might start to relax, especially the very top layers
- AlGaAs barrier might be too thick, resulting in lower electron mobility and shorter carrier lifetime
- Spin relaxation time in GaSb (~ 1 ps) is shorter than that in GaAs (>7 ps)

Next Step

- **Remove strain relaxation**

1. More detailed analysis on GaAsSb/AlGaAs SL (Strain relaxation percentage, XRD reciprocal space mapping)
2. Lower Sb composition in SL

- **Minimize transport loss**

1. Thinner AlGaAs barrier and lower Al composition
2. Further improvement of material quality

- **Reduce spin relaxation**

Lower Sb and Al composition

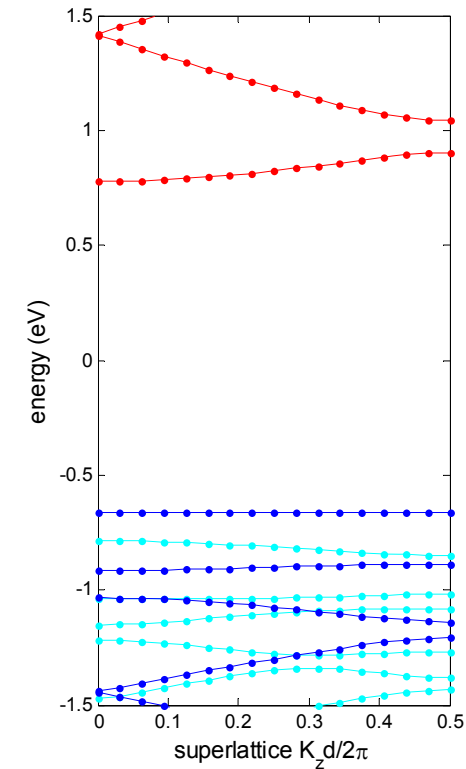
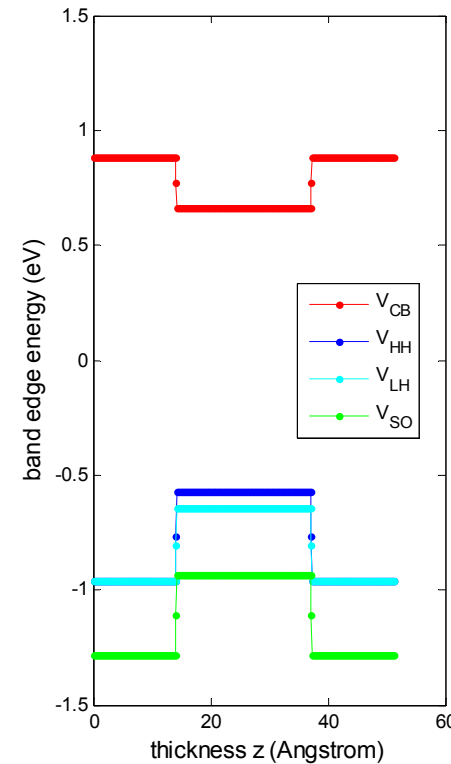
Modified SL design (right)

Initial polarization:

~96% @ $\gamma=10$ meV

~93% @ $\gamma=10$ meV

GaAsSb_{0.12}/Al_{0.30}GaAs, 8-10 ML



HH-LH splitting = 123.56 meV
 $m^* = 0.0755$, electron mobility 3845.54

